organic compounds

Acta Crystallographica Section C Crystal Structure Communications ISSN 0108-2701

2-Benzoyl-*N*-phenyl-2-(1,2,4-triazol-1-yl)thioacetamide and 2-(4-methoxybenzoyl)-*N*-phenyl-2-(1,2,4-triazol-1-yl)thioacetamide

Fang-Fang Jian,* Hai-Lian Xiao, Yong-Qi Qin and Liang-Zhong Xu

New Materials and Function Coordination Chemistry Laboratory, Qingdao University of Science and Technology, Qingdao 266042, People's Republic of China Correspondence e-mail: ffj2003@163169.net

Received 5 April 2004 Accepted 20 May 2004 Online 22 June 2004

In the two title compounds, $C_{17}H_{14}N_4OS$, (I), and $C_{18}H_{16}N_4$ -O₂S, (II), the dihedral angles between the planes of the triazole and *N*-phenyl rings and the plane of five of the atoms that link these two rings are 63.5 (8) and 73.2 (6)° for (I), and 65.1 (1) and 72.1 (3)° for (II), respectively. There are some inter- and intramolecular interactions in the crystal structure.

Comment

Recently, compounds containing the 1*H*-1,2,4-triazole group have attracted much interest because they exhibit some fungicidal activity and plant-growth regulating activity (Xu *et al.*, 2002), and show antibacterial activity against *Puccinia recondite* and root-growth regulation for cucumber (Zhao *et al.*, 1998). In order to search for new triazole compounds with higher bioactivity, we synthesized the title compounds, (I) and (II). Their structures are described here.



In the title compounds (Figs. 1 and 2), the bond lengths and angles are generally normal in the *N*-phenyl and triazole rings (Ji *et al.*, 2002). The C=S bond length (Tables 1 and 3) in each compound is close to the typical C=S double-bond length. Atom C8 lies in the plane of the triazole ring, and atoms S1, C6, C7, C8 and N1 are coplanar (plane *p*1). The dihedral angles formed by the C1–C6 and triazole rings with *p*1 are 63.5 (8) and 73.2 (6)° for (I), and 65.1 (1) and 72.1 (3)° for (II), respectively. These values indicate that the addition of the methoxy group to the C12–C17 benzene ring has little influ-



Figure 1

The structure of (I), showing 50% probability displacement ellipsoids and the atom-numbering scheme.





The structure of (II), showing 50% probability displacement ellipsoids and the atom-numbering scheme.

ence on the molecular conformation. The C1-C6-N1-C7, N2-N4-C8-C7, N2-N4-C8-C11 and N4-C8-C11-C12 torsion angles are 25.3 (5), 88.5 (0), 147.4 (6) and 175.5 (6)° for (I), and 13.1 (0), 88.8 (8), 147.5 (9) and 171.3 (8)° for (II), respectively. The C14-C15-O2-C18 torsion angle is 173.0 (6)° for (II).

The most interesting structural features of the two complexes are the $N-H \cdots N$ intermolecular hydrogen bonds and the weak ($C-H \cdots Y$ hydrogen bonds; Y = O, N and S) intermolecular interactions (see Tables 2 and 4). These interactions stabilize the two structures.

Experimental

The title compounds were prepared by the reaction of α -(1,2,4-triazol-1-yl)acetophenone, phenyl isothiocynate [for (I)] or methoxyphenyl isothiocynate [for (II)], and potassium hydroxide in dimethyl sulfoxide solution. Single crystals of the title compounds suitable for X-ray measurements were obtained by recrystallization from chloroform/ethyl acetate (1:3 ν/ν) at room temperature.

Compound (I)

Crystal data

C17H14N4OS $M_r = 322.38$ Monoclinic, $P2_1/c$ a = 8.8060 (18) Åb = 12.097 (2) Å c = 14.809(3) Å $\beta = 105.88 (3)^{\circ}$ V = 1517.3 (6) Å³ Z = 4

Data collection

Rigaku R-AXIS-IV Imaging Plate diffractometer Oscillation frame scans 5518 measured reflections 3055 independent reflections 2314 reflections with $I > 2\sigma(I)$ $R_{\rm int} = 0.023$

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F_o^2) + (0.0488P)^2]$
$R[F^2 > 2\sigma(F^2)] = 0.040$	+ 0.2377P]
$wR(F^2) = 0.103$	where $P = (F_o^2 + 2F_c^2)/3$
S = 1.09	$(\Delta/\sigma)_{\rm max} < 0.001$
3055 reflections	$\Delta \rho_{\rm max} = 0.21 \text{ e } \text{\AA}^{-3}$
209 parameters	$\Delta \rho_{\rm min} = -0.19 \text{ e } \text{\AA}^{-3}$
H-atom parameters constrained	Extinction correction: SHEI
	Extinction coefficient: 0.0133

Table 1

Selected interatomic distances (Å) for (I).

S1-C7	1.6536 (18)	N1-C6	1.425 (2)
O1-C11	1.214 (2)	N2-C9	1.314 (2)
N1-C7	1.342 (2)	N2-N4	1.368 (2)

Table 2

Hydrogen-bonding geometry (Å, °) for (I).

D H4	лн	H4	$D \dots A$	D H4
D=II···A	$D=\Pi$	II···A	D	D=II···A
$N1-H1A\cdots N3^{i}$	0.86	2.14	2.998 (2)	174
$C1 - H1B \cdot \cdot \cdot S1$	0.93	2.67	3.248 (2)	120
C10−H10A···O1	0.93	2.40	2.758 (3)	103

Symmetry code: (i) 2 - x, $y - \frac{1}{2}, \frac{1}{2} - z$.

Compound (II)

Crystal data

$C_{18}H_{16}N_4O_2S$	$D_x = 1.383 \text{ Mg m}^{-3}$
$M_r = 352.41$	Mo $K\alpha$ radiation
Monoclinic, P_{2_1}/c	Cell parameters from 20
a = 9.806 (2) Å	reflections
b = 11.677 (2) Å	$\theta = 2 - 11^{\circ}$
c = 16.002(5) Å	$\mu = 0.21 \text{ mm}^{-1}$
$\beta = 112.55 \ (2)^{\circ}$	T = 293 (2) K
V = 1692.2 (7) Å ³	Pillar, yellow
Z = 4	$0.25\times0.20\times0.15~\mathrm{mm}$
- · · ·	
Data collection	
Rigaku R-AXIS-IV Imaging Plate	$\theta_{\rm max} = 25.9^{\circ}$

 $h = 0 \rightarrow 12$

 $k = -13 \rightarrow 13$

 $l=-20\rightarrow 18$

3 standard reflections

every 100 reflections intensity decay: none

Rigaku R-AXIS-IV Imaging Plate
diffractometer
Oscillation frame scans
5351 measured reflections
3195 independent reflections
2209 reflections with $I > 2\sigma(I)$
$R_{\rm int} = 0.029$

Mo $K\alpha$ radiation Cell parameters from 20 reflections $\theta = 2 {-} 11^\circ$ $\mu = 0.22 \text{ mm}^{-1}$ T = 293 (2) KPillar, yellow $0.25 \times 0.20 \times 0.15 \text{ mm}$

 $D_x = 1.411 \text{ Mg m}^{-3}$

$\theta_{\rm max} = 26.5^{\circ}$
$h = -10 \rightarrow 0$
$k = -15 \rightarrow 15$
$l = -17 \rightarrow 19$
3 standard reflections
every 100 reflections
intensity decay: none

LXL973 (17)

Refinement

Refinement on F^2	$w = 1/[\sigma^2(F^2 + (0.1328P)^2)]$
$R[F^2 > 2\sigma(F^2)] = 0.078$	+ 0.7232P]
$wR(F^2) = 0.240$	where $P = (F_{a}^{2} + 2F_{c}^{2})/3$
S = 1.12	$(\Delta/\sigma)_{\rm max} < 0.001$
3195 reflections	$\Delta \rho_{\rm max} = 1.10 \ {\rm e} \ {\rm \AA}^{-3}$
227 parameters	$\Delta \rho_{\rm min} = -0.33 \text{ e } \text{\AA}^{-3}$
H-atom parameters constrained	Extinction correction: SHELXL97
	Extinction coefficient: 0.013 (4)

Table 3

Selected interatomic distances (Å) for (II).

S1-C7	1.653 (4)	N1-C7	1.339 (5)
O1-C11	1.217 (4)	N1-C6	1.427 (5)
O2-C15	1.379 (5)	N2-C9	1.317 (6)
O2-C18	1.389 (6)	N2-N4	1.359 (5)

Table 4

Hydrogen-bonding geometry (Å, °) for (II).

$D-\mathrm{H}\cdots A$	$D-\mathrm{H}$	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdots A$
$N1-H1A\cdots N3^{ii}$	0.86	2.22	3.076 (5)	175
$C1 - H1B \cdot \cdot \cdot S1$	0.93	2.62	3.256 (6)	126
C8-H8A···N3 ⁱⁱ	0.98	2.63	3.537 (5)	154
C10−H10A···O1	0.93	2.42	2.811 (6)	105

Symmetry code: (ii) $1 - x, \frac{1}{2} + y, \frac{1}{2} - z$.

H atoms were positioned geometrically and treated as riding on their parent C atoms, with C-H distances in the range 0.93-0.98 Å and $U_{iso}(H)$ values of 1.2 and 1.5 times the U_{eq} values of the parent atoms.

For both compounds, data collection: R-AXIS Software (Rigaku, 1997); cell refinement: R-AXIS Software; data reduction: R-AXIS Software; program(s) used to solve structure: SHELXS97 (Sheldrick, 1990a); program(s) used to refine structure: SHELXL97 (Sheldrick, 1997); molecular graphics: SHELXTL/PC (Sheldrick, 1990b); software used to prepare material for publication: WinGX (Farrugia, 1999).

The authors thank the Natural Science Foundation of Shandong Province (grant No. Y2002B06).

Supplementary data for this paper are available from the IUCr electronic archives (Reference: NA1659). Services for accessing these data are described at the back of the journal.

References

- Farrugia, L. J. (1999). J. Appl. Cryst. 32, 837-838.
- Ji, B. M., Du, C. X., Zhu, Y. & Wang, Y. (2002). Chin. J. Struct. Chem. 21, 252-255.
- Rigaku (1997). R-AXIS Software. Rigaku Corporation, Tokyo, Japan.
- Sheldrick, G. M. (1990a). Acta Cryst. A46, 467-473.
- Sheldrick, G. M. (1990b). SHELXTL/PC. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.
- Sheldrick, G. M. (1997). SHELXL97. University of Göttingen, Germany. Xu, L. Z., Zhang, S. S., Li, H. J. & Jiao, K. (2002). Chem. Res. Chin. Univ. 18,
- 284-286. Zhao, G. F., Jin, G. Y., Liu, Z. F., Ren, J. & Li, Y. C. (1998). Chin. J. Chem. 16, 363-366.